

Not Just Chips

April 4-6, 2023





Challenges to Develop a Reliable Lead Free Solder Column to Replace Solder Balls in Large Heterogeneous Packages

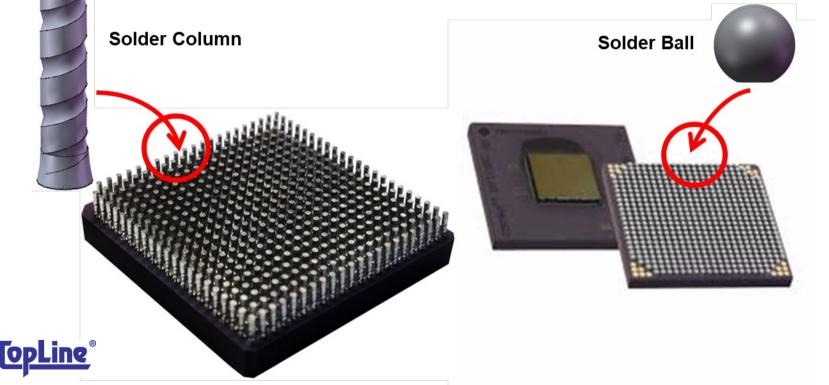


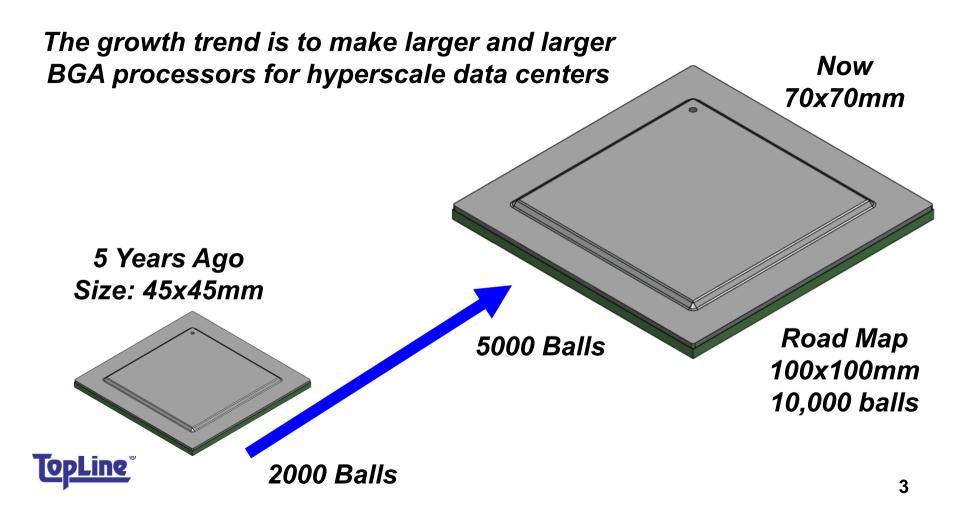
Martin Hart – TopLine Corporation



Braided Column

Solder Balls are subject to failure (delamination) caused by excessive stresses inherently found in super-sized heterogeneous 2.5D packages





Package designers are constrained by available solutions to mitigate stresses inside humongous sized 2.5D processors.

Typical design tricks:

- Copper Balancing
- Low CTE Organic Materials
- Stiffeners
- Other Secret Sauce



Solder columns (instead of solder balls) could be a reliable solution to tame destructive stresses.

Legacy:

Tin-Lead (SnPb) Solder Columns have a 40 year track record for reducing stress in connecting large ceramic FPGA and ASIC packages to PC Boards for the Defense and Aerospace market.

Next Gen:

Make Lead Free (RoHS) solder columns that provide adequate stress relief in very large commercial packages.



What we are doing:

We are developing a next generation Lead Free solder column with an exoskeleton copper braided sleeve to replace solder balls for use on large sized Heterogeneous 2.5D processors.

Ready:

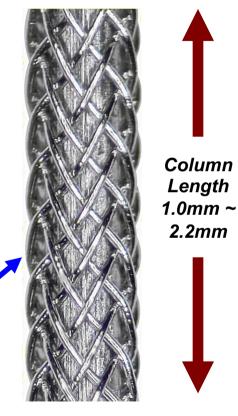
Engineering samples Q3 – 2023 Production ready Q1 - 2024





Solder Column relative size

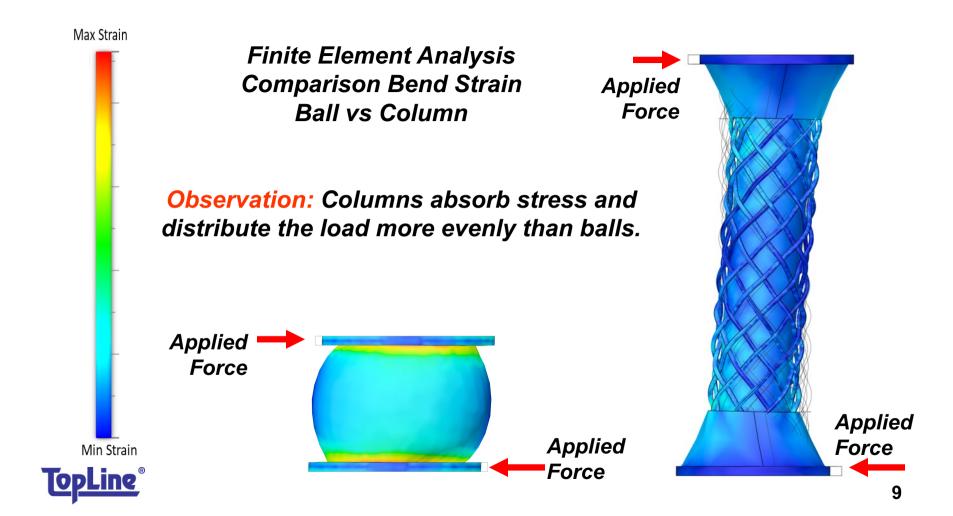
Magnification 200X



16 strands 1.0 mil copper wire braided over Lead Free solder core







Benefits of Braided Solder Columns compared to solder balls:

- Columns are non-collapsible and absorb package strain.
- Balls collapse and fail under strain as packages get larger.
- Columns have unique 16 strand copper sleeve construction.
- Columns lower thermal impedance carries heat from package.
- Columns have potential to reduce need for package heat sink.
- Columns reduced stress between the package and the PCB.



Summary:

Column technology supports the market trend for scaling up the size of 2.5D chips to 100mm x 100mm while maintaining package reliability.



Take away: Columns have the potential to increase package life over more thermal cycles.

Let's continue the conversation!

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